

PTC thermistors for overcurrent protection

SMDs, EIA sizes 3225 and 4032, 63 V

Series/Type: B59115, B59215, B59315

Date: January 2011

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SMDs, EIA sizes 3225 and 4032, 63 V

Applications

- Overcurrent protection
- Short circuit protection

Features

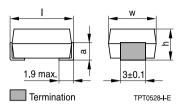
- Molded epoxy encapsulation, lead-free tinned solder terminals
- Suitable for wave and reflow soldering
- Suitable for automatic placement
- Qualification based on AEC-Q200, Rev. D
- RoHS-compatible

Delivery mode

■ Blister tape, 330-mm reel with 16-mm tape, taping to IEC 60286-3

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Dimensional drawing

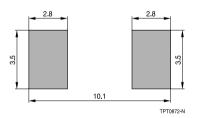


Dimensions (mm)

Type	h ±0.5	w ±0.5	I ±0.5	a ±0.3	Size
Refere	nce temp	erature =	80 °C		
P1115	3.3	6.3	8.0	1.7	3225
P1215	3.3	6.3	8.0	1.7	3225
P1315	3.3	8.0	10.0	2.3	4032
Reference temperature = 120 °C					
P1115	3.3	6.3	8.0	1.7	3225
P1215	3.3	6.3	8.0	1.7	3225
P1315	3.3	8.0	10.0	2.3	4032

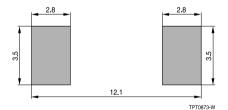
Geometry of solder pads

EIA case size 3225



Recommended maximum dimensions (mm)

EIA case size 4032



General technical data

Max. operating voltage	(T _A = 60 °C)	V_{max}	80	V DC or V AC
Rated voltage		V _R	63	V DC or V AC
Switching cycles		N	100	
Tolerance of R _R		ΔR_R	±25	%
Operating temperature range	(V = 0)	T _{op}	-40/+125	°C
Operating temperature range	$(V = V_{max})$	T _{op}	-40/+60	°C



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Electrical specifications and ordering codes

Туре	I _R	Is	I _{Smax}	I _r	R _R	R _{min}	Ordering code
			$(V = V_{max})$	(typ.)			
				$(V = V_{max})$			
	mA	mA	Α	mA	Ω	Ω	
Reference	Reference temperature = T _{ref} = 80 °C						
P1315	80	165	1.6	15.0	16	9.6	B59315P1080A062
P1215	65	135	1.0	11.5	25	15.0	B59215P1080A062
P1115	40	85	0.7	9.0	55	32.2	B59115P1080A062
Reference	Reference temperature = T _{ref} = 120 °C						
P1315	150	310	1.6	20.0	16	9.6	B59315P1120A062
P1215	100	210	1.0	14.0	25	15.0	B59215P1120A062
P1115	70	145	0.7	13.0	55	32.2	B59115P1120A062

Reliability data

Test	Standard	Test conditions	$ \Delta R_{25}/R_{25} $
Electrical endurance,	IEC 60738-1	Room temperature, I _{Smax} ; V _{max}	< 25%
cycling		Number of cycles: 100	
Electrical endurance,	IEC 60738-1	Storage at V _{max} /T _{op,max} (V _{max})	< 25%
constant		Test duration: 1000 h	
Damp heat	IEC 60738-1	Temperature of air: 40 °C	< 10%
		Relative humidity of air: 93%	
		Duration: 56 days	
		Test according to IEC 60068-2-78	
Rapid change	IEC 60738-1	$T_1 = T_{op,min} (0 \text{ V}), T_2 = T_{op,max} (0 \text{ V})$	< 10%
of temperature		Number of cycles: 5	
		Test duration: 30 min	
		Test according to IEC 60068-2-14, Test Na	
Shock	IEC 60738-1	Acceleration: 390 m/s ²	< 5%
		Pulse duration: 6 ms; 6 × 4000 pulses	
Bending test	EN 130000/4.35	Components reflow-soldered to test board	< 10%
		Maximum bending: 2 mm	

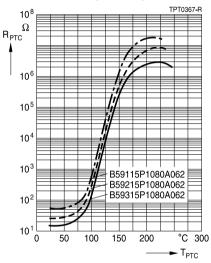


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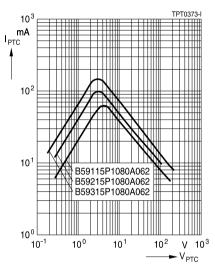
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Characteristics (typical) for T_{ref} = 80 °C

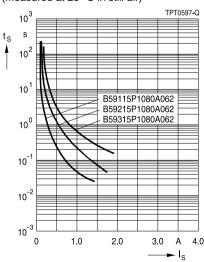
PTC resistance R_{PTC} versus PTC temperature T_{PTC} (measured at low signal voltage)



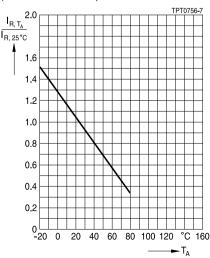
PTC current I_{PTC} versus PTC voltage V_{PTC} (measured at 25 °C in still air)



Switching time t_s versus switching current I_s (measured at 25 °C in still air)



Rated current I_R versus ambient temperature T_A (measured in still air)



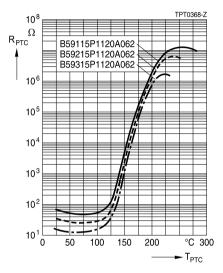


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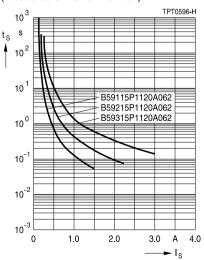
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Characteristics (typical) for T_{ref} = 120 °C

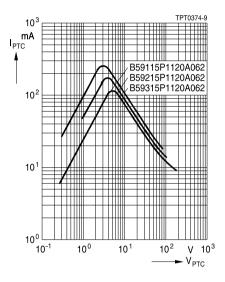
PTC resistance R_{PTC} versus PTC temperature T_{PTC} (measured at low signal voltage)



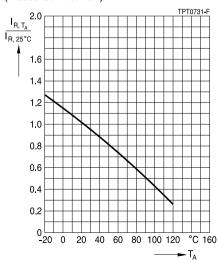
Switching time t_{S} versus switching current I_{S} (measured at 25 °C in still air)



PTC current I_{PTC} versus PTC voltage V_{PTC} (measured at 25 °C in still air)



Rated current I_R versus ambient temperature T_A (measured in still air)





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Taping and packing

Many of the components presented in this data book are suitable for processing on automatic insertion or placement machines. These thermistors can be supplied on tape for easy handling by automatic systems. The individual modes of taping and packing will be described in the following.

1 Taping of SMD thermistors

1.1 Blister tape (to IEC 60286-3)

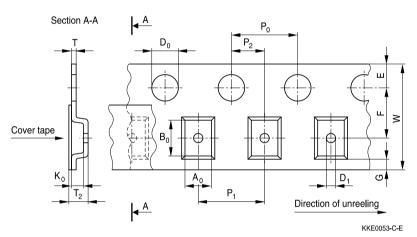


Figure 1

Dimension (mm)	8-mm tape	16-mm tape	Tolerance (mm)	24-mm tape	Tolerance (mm)
D_0	1.50	1.50	+ 0.10/-0	1.50	+ 0.10
D_1	1.00	1.50	min.	1.50	+ 0.10
P_0	4.00	4.00	± 0.10 1)	4.00	± 0.10
P_2	2.00	2.00	± 0.05	2.00	± 0.10
P ₁	4.00	12.00	± 0.10	16.00	± 0.10
W	8.00	16.00	± 0.30	24.00	+ 0.30/-0.1
E	1.75	1.75	± 0.10	1.75	± 0.10
F	3.50	7.50	± 0.05	11.50	± 0.10
G	0.75	0.75	min.	0.75	min.

 $A_0 \times B_0$, K_0 , T_2 : The rated dimensions of the component compartment have been derived from the relevant component specification and are chosen such that the components cannot change their orientation within the tape.

^{1) ≤ 0.2} mm over 10 sprocket holes



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Part orientation in tape pocket for blister tape

For chip thermistors case sizes 0805 and 1210

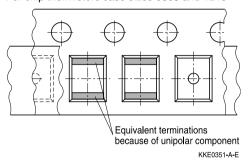


Figure 2

Additional taping information

For chip thermistors case sizes 0805 and 1210

Reel material	Polystyrol (PS)
Tape material	Polystyrol (PS) or Polycarbonat (PC) or PVC
Tape break force	min. 10 N
Top cover tape strength	min. 10 N
Top cover tape peel force	0.2 0.6 N for 8-mm tape and 0.2 0.8 N for 12-mm tape at a peel speed of 300 mm/min
Tape peel angle	Angle between top cover tape and the direction of feed during peel off: 165° 180°
Cavity play	Each part rests in the cavity so that the angle between the part and cavity center line is no more than 20°



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1.2 Cardboard tape (to IEC 60286-3)

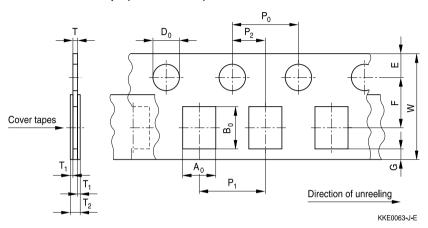


Figure 3

Dimensions (mm)	8-mm tape Tolerance (mm)		
	Case	e size	
	0402	0603	
$\overline{A_0}$	0.6	0.95	±0.2
B ₀	1.15	1.8	±0.2
T	0.6	0.95	±0.05
T_2	0.75	1.1	max.
D_0	1.5		+0.1/-0
P ₀	4.0	4.0	±0.1 ²⁾
P_2	2.0	2.0	±0.05
P ₁	2.0	4.0	±0.1
W	8.0 ±0.3		
E	1.75 ±0.1		
F	3.5		±0.05
G	0.75 min.		

^{2) ≤0.2} mm over 10 sprocket holes.



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Part orientation in tape pocket for cardboard tape

For chip thermistors case sizes 0402 and 0603

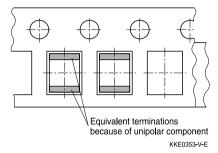


Figure 4

Additional taping information

Reel material	Polystyrol (PS)
Tape material	Cardboard
Tape break force	min. 10 N
Top cover tape strength	min. 10 N
Top cover tape peel force	0.1 0.65 N at a peel speed of 300 mm/min
Tape peel angle	Angle between top cover tape and the direction of feed during peel off: 165° 180°
Cavity play	Each part rests in the cavity so that the angle between the part and cavity center line is no more than 20°



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1.3 Reel dimensions

180-mm reel with 8-mm tape

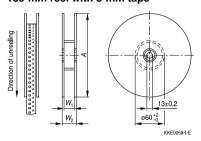


Figure 5

Dimension	180-mm reel
A	180 -2/+0
W ₁	8.4 +1.5/-0
W ₂	14.4 max.

330-mm reel with 16-mm tape

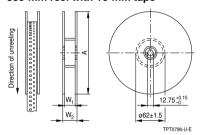


Figure 6

Dimension	330-mm reel
A	330 -2/+0
$\overline{W_{1}}$	16.4 +2.0/-0
$\overline{W_2}$	22.4 max.

330-mm reel with 24-mm tape

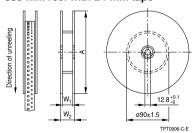


Figure 7

Dimension	330-mm reel
A	330 -2/+0
$\overline{W_1}$	24.4 min.
$\overline{W_2}$	30.4 max.

380-mm reel with 24-mm tape

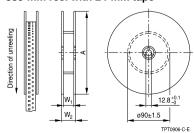


Figure 8

Dimension	380-mm reel
A	380 -2/+0
W ₁	24.4 min.
$\overline{W_{2}}$	30.4 max.



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Mounting instructions

1 Soldering

1.1 Leaded PTC thermistors

Leaded PTC thermistors follow the solderability requirements of IEC 60068-2-20.

During soldering, care must be taken that the thermistors are not damaged by excessive heat. The following maximum temperatures, maximum time spans and minimum distances have to be observed:

	Solder containing lead	Lead-free solder
	(SnPb 60/40)	(Sn96.5Ag3Cu0.5)
Solderability	Solder bath temperature 230 °C	Solder bath temperature 245 °C
	Soldering time 3 s	Soldering time 3 s
Resistance to	Soldering iron temperature 350 °C	Solder bath temperature 260 °C
soldering heat	Soldering time 3 s	Soldering time 10 s

Distance to thermistor has to be ≥6 mm. Under more severe soldering conditions the resistance may change. Soldering conditions for wave soldering are given in chapter 1.4.1.

1.2 Leadless PTC thermistors

In case of PTC thermistors without leads, soldering is restricted to devices which are provided with a solderable metallization. The temperature shock caused by the application of hot solder may produce fine cracks in the ceramic, resulting in changes in resistance.

In addition, soldering methods should be employed which permit short soldering times.

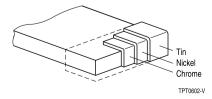
Soldering conditions for wave soldering are given in chapter 1.4.1.

1.3 SMD PTC thermistors

The notes on soldering leadless thermistors also apply to the SMD versions (refer to IEC 60068-2-58). Soldering conditions for wave soldering are given in chapter 1.4.1., for reflow soldering in chapter 1.4.2.

1.3.1 Chrome/nickel/tin terminations

(Sizes 0402, 0603, 0805, 1210)



As shown in the figure above, the terminations consists of three metallic layers. A primary chrome layer provides for good electrical contact. "Leaching" is prevented by a nickel barrier layer. The outer tin coating prevents corrosion of the nickel and ensures good component solderability.



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1.3.2 Test methods for wetting and resistance to soldering heat

a) Solder bath method according to IEC 60068-2-58

Applicable for SMD components with wire or tag terminations. In case the SMD-component does not have a completely closed housing, only the wires or tags may be immersed into the solder bath.

	Lead-free solder	Solder containing lead	
	(Sn96.5Ag3Cu0.5)	(SnPb 60/40)	
Wetting test	Bath temperature 250 °C	Bath temperature 215 °C	
	Soldering time 3 s	Soldering time 3 s	
Resistance to	Bath temperature 260 °C	Bath temperature 260 °C	
soldering heat	Soldering time 10 s	Soldering time 10 s	

b) Solder reflow method according to IEC 60068-2-58

Applicable for chip-style SMD components. Reflow temperature profile is stated in IEC 60068-2-58, 8.1.2.1 for wetting test and 8.1.2.2 for resistance to soldering heat test.

	Lead-free solder	Solder containing lead	
	(Sn96.5Ag3Cu0.5)	(SnPb 60/40)	
Wetting test	Peak temperature 225 235 °C		
	Duration maximum 20 s	Duration maximum 10 s	
Resistance to	Peak temperature 245 255 °C	Peak temperature 235 °C	
soldering heat	Duration maximum 20 s	Duration maximum 30 s	



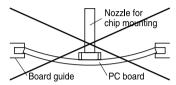
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1.3.3 Placement and orientation of SMDs on PCB

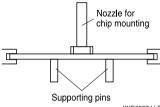
a) Component placement

Incorrect



It is recommended that the PC board should be held by means of some adequate supporting pins such as shown left to prevent the SMDs from being damaged or cracked.

Correct

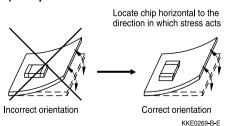


KKE0267-U-E

b) Cracks

When placing a component near an area which is apt to bend or a grid groove on the PC board, it is advisable to have both electrodes subjected to uniform stress, or to position the component's electrodes at right angles to the grid groove or bending line.

c) Component orientation



Choose a mounting position that minimizes the stress imposed on the chip during flexing or bending of the board.

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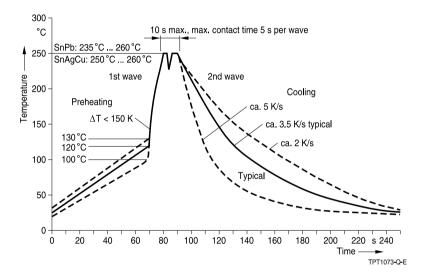
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1.4 Soldering profiles

1.4.1 Wave soldering

Recommended temperature profile for wave soldering following IEC 61760-1. Applicable for leaded PTCs and selected SMD PTCs (case sizes 3225 and 4032 as well as superior series for case sizes 0402, 0603 and 0805 limit temperature sensors).



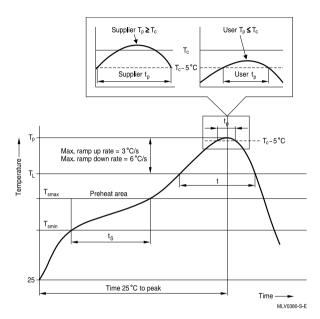


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1.4.2 Reflow soldering

Recommended temperature characteristic for reflow soldering following JEDEC J-STD-020D



B (1) ()	Ī		D. (
Profile feature		Sn-Pb eutectic assembly	Pb-free assembly	
Preheat and soak				
- Temperature min	T_{smin}	100 °C	150 °C	
- Temperature max	T _{smax}	150 °C	200 °C	
- Time	t_{smin} to t_{smax}	60 120 s	60 180 s	
Average ramp-up rate	T_{smax} to T_p	3 °C/ s max.	3 °C/ s max.	
Liquidous temperature	T _L	183 °C	217 °C	
Time at liquidous	t∟	60 150 s	60 150 s	
Peak package body temperature	$T_p^{1)}$	220 °C 235 °C ²⁾	245 °C 260 °C ²⁾	
Time (t _P) ³⁾ within 5 °C of specified		20 s ³⁾	30 s ³⁾	
classification temperature (T _c)	20 s ^s /		30 8%	
Average ramp-down rate	T _p to T _{smax}	6 °C/ s max.	6 °C/ s max.	
Time 25 °C to peak temperature		maximum 6 min	maximum 8 min	

¹⁾ Tolerance for peak profile temperature (T_P) is defined as a supplier minimum and a user maximum.

Note: All temperatures refer to topside of the package, measured on the package body surface. Number of reflow cycles: 3

²⁾ Depending on package thickness. For details please refer to JEDEC J-STD-020D.

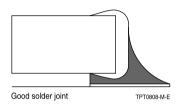
³⁾ Tolerance for time at peak profile temperature (t_p) is defined as a supplier minimum and a user maximum.

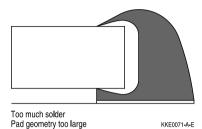


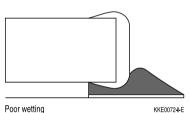
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1.4.3 Solder joint profiles for PTC theristors with chrome/nickel/tin terminations







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2 Storage of PTC thermistors

PTC thermistors should be soldered after shipment from EPCOS within the time specified: Use thermistor within the following period after delivery:

Through-hole devices (housed and leaded PTCs)	24 months
Motor protection sensors, glass-encapsulated sensors and probe assemblies	24 months
Telecom pair and quattro protectors (TPP, TQP)	24 months
Leadless PTC thermistors for pressure contacting	12 months
Leadless PTC thermistors for soldering	6 months
SMDs in EIA sizes 3225 and 4032, and for PTCs with metal tags	24 months
SMDs in EIA sizes 0402, 0603, 0805 and 1210	12 months

The parts are to be left in the original packing.

Storage temperature: $-25 ... + 45 \,^{\circ}\text{C}$

Relative humidity: $\leq 75\%$ annual average, $\leq 95\%$ on 30 days in a year

The solderability of the external electrodes may be deteriorated if SMDs are stored where they are exposed to high humidity, dust or harmful gas (hydrogen chloride, sulfuric acid gas or hydrogen sulfide).



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Do not store SMDs where they are exposed to heat or direct sunlight. Otherwise, the packing material may be deformed or SMDs may stick together, causing problems during mounting.

After opening the factory seals, such as polyvinyl-sealed packages, it is recommended to use the components as soon as possible.

3 Conductive adhesion

An alternative to soldering is the gluing of thermistors with conductive adhesives. The benfit of this method is that it involves no thermal stress. The adhesives used must be chemically inert and suitable for the temperatures arising at the surface of the termistor.

4 Clamp contacting

Pressure contacting by springs is required for applications involving frequent switching and high turn-on powers. Soldering is not allowed for such applications in order to avoid operational failure in the long term. PTC thermistors for heating and motor starting have metallized surfaces for clamp contacting.

5 Robustness of terminations

The leads meet the requirements of IEC 60068-2-21. They may not be bent closer than 4 mm from the solder joint on the thermistor body or from the point at which they leave the feedthroughs. During bending, any mechanical stress at the outlet of the leads must be removed. The bending radius should be at least 0.75 mm.

Tensile strength: Test Ua1:

Leads

 $\emptyset \le 0.5 \text{ mm} = 5 \text{ N}$

 $\emptyset > 0.5 \text{ mm} = 10 \text{ N}$

Bending strength: Test Ub:

Two 90°-bends in opposite directions at a weight of 0.25 kg.

Torsional strength: Test Uc: severity 2

The lead is bent by 90° at a distance of 6 to 6.5 mm from the thermistor body.

The bending radius of the leads should be approx. 0.75 mm. Two torsions of

 180° each (severity 2).



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When subjecting leads to mechanical stress, the following should be observed:

Tensile stress on leads

During mounting and operation tensile forces on the leads are to be avoided.

Bending of leads

Bending of the leads directly on the thermistor body is not permissible.

A lead may be bent at a minimum distance of twice the wire's diameter +2 mm from the solder joint on the thermistor body. During bending the wire must be mechanically relieved at its outlet. The bending radius should be at least 0.75 mm.

Twisting of leads

The twisting (torsion) by 180° of a lead bent by 90° is permissible at 6 mm from the bottom of the thermistor body.

6 Sealing and potting

When thermistors are sealed or potted, there must be no mechanical stress through differing thermal expansion in the curing process and during later operation. In the curing process the upper category temperature of the thermistor must not be exceeded. It is also necessary to ensure that the potting compound is chemically inert.

Sealing and potting compounds may degenerate the titanate ceramic of PTC thermistors and lead to the formation of low-ohmic conduction bridges. In conjunction with a change in dissipation conditions due to the potting compound, local overheating may finally damage the thermistor.

Therefore sealing and potting should be avoided whenever possible.

7 Cleaning

You may use common cleaners based on organic solvents (eg dowanol or alcohol) to clean ceramic and solder joints.

For sufficient cleaning flux must be completely removed.

Solvents may cause plastic encapsulations to swell or detach. So be sure to check the suitability of a solvent before using it.

Caution is required with ultrasonic processes. If the sound power is too high, for example, it can degrade the adhesive strength of the terminal metallization or couse the encapsulation to detach.

After cleaning drying is promptly necessary.



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Cautions and warnings

General

- EPCOS thermistors are designed for specific applications and should not be used for purposes not identified in our specifications, application notes and data books unless otherwise agreed with EPCOS during the design-in-phase.
- Ensure suitability of thermistor through reliability testing during the design-in phase. The thermistors should be evaluated taking into consideration worst-case conditions.

Storage

- Store thermistors only in original packaging. Do not open the package before storage.
- Storage conditions in original packaging: storage temperature −25 °C ... +45 °C, relative humidity ≤75% annual mean, maximum 95%, dew precipitation is inadmissible.
- Avoid contamination of thermistors surface during storage, handling and processing.
- Avoid storage of thermistor in harmful environment with effect on function on long-term operation (examples given under operation precautions).
- Use thermistor within the following period after delivery:
 - Through-hole devices (housed and leaded PTCs): 24 months
 - Motor protection sensors, glass-encapsulated sensors and probe assemblies: 24 months
 - Telecom pair and quattro protectors (TPP, TQP): 24 months
 - Leadless PTC thermistors for pressure contacting: 12 months
 - Leadless PTC thermistors for soldering: 6 months
 - SMDs in EIA sizes 3225 and 4032, and for PTCs with metal tags: 24 months
 - SMDs in EIA sizes 0402, 0603, 0805 and 1210: 12 months

Handling

- PTCs must not be dropped. Chip-offs must not be caused during handling of PTCs.
- Components must not be touched with bare hands. Gloves are recommended.
- Avoid contamination of thermistor surface during handling.

Soldering (where applicable)

- Use rosin-type flux or non-activated flux.
- Insufficient preheating may cause ceramic cracks.
- Rapid cooling by dipping in solvent is not recommended.
- Complete removal of flux is recommended.
- Standard PTC heaters are not suitable for soldering.



SMDs, EIA sizes 3225 and 4032, 63 V

SMD

Mounting

- Electrode must not be scratched before/during/after the mounting process.
- Contacts and housing used for assembly with thermistor have to be clean before mounting. Especially grease or oil must be removed.
- When PTC thermistors are encapsulated with sealing material, the precautions given in chapter "Mounting instructions", "Sealing and potting" must be observed.
- When the thermistor is mounted, there must not be any foreign body between the electrode of the thermistor and the clamping contact.
- The minimum force of the clamping contacts pressing against the PTC must be 10 N.
- During operation, the thermistor's surface temperature can be very high. Ensure that adjacent components are placed at a sufficient distance from the thermistor to allow for proper cooling at the thermistors.
- Ensure that adjacent materials are designed for operation at temperatures comparable to the surface temperature of thermistor. Be sure that surrounding parts and materials can withstand this temperature.
- Avoid contamination of thermistor surface during processing.

Operation

- Use thermistors only within the specified temperature operating range.
- Use thermistors only within the specified voltage and current ranges.
- Environmental conditions must not harm the thermistors. Use thermistors only in normal atmospheric conditions. Avoid use in deoxidizing gases (chlorine gas, hydrogen sulfide gas, ammonia gas, sulfuric acid gas etc), corrosive agents, humid or salty conditions. Contact with any liquids and solvents should be prevented.
- Be sure to provide an appropriate fail-safe function to prevent secondary product damage caused by abnormal function (e.g. use VDR for limitation of overvoltage condition).



SMDs, EIA sizes 3225 and 4032, 63 V

SMD

Symbols and terms

A Area

 $\begin{array}{ll} C_{th} & & \text{Heat capacity} \\ f & & \text{Frequency} \\ I & & \text{Current} \end{array}$

 I_{max}
 Maximum current

 I_R
 Rated current

 I_{PTC}
 PTC current

 I.
 Residual current

 $\begin{array}{ll} {\rm I_{r,{\rm oil}}} & {\rm Residual~currrent~in~oil~(for~level~sensors)} \\ {\rm I_{r,air}} & {\rm Residual~currrent~in~air~(for~level~sensors)} \end{array}$

I_{RMS} Root-mean-square value of current

I_S Switching current

I_{Smax} Maximum switching current LCT Lower category temperature

N Number (integer)

N_c Operating cycles at V_{max}, charging of capacitor

N_f Switching cycles at V_{max}, failure mode

P Power

P₂₅ Maximum power at 25 °C

P_{el} Electrical powerP_{diss} Dissipation power

R_G Generator internal resistance

 $\begin{array}{lll} R_{\text{min}} & & \text{Minimum resistance} \\ R_{\text{R}} & & \text{Rated resistance} \\ \Delta R_{\text{R}} & & \text{Tolerance of } R_{\text{R}} \\ R_{\text{P}} & & \text{Parallel resistance} \\ R_{\text{PTC}} & & \text{PTC resistance} \end{array}$

 R_{ref} Reference resistance R_{S} Series resistance R_{25} Resistance at 25 °C

Resistance matching per reel/ packing unit at 25 °C

 ΔR_{25} Tolerance of R_{25} T Temperature

t Time

T_A Ambient temperaturet_a Thermal threshold time

T_C Ferroelectric Curie temperature



SMDs, EIA sizes 3225 and 4032, 63 V

SMD

t_E Settling time (for level sensors)

 $\begin{array}{lll} T_{\text{R}} & & \text{Rated temperature} \\ T_{\text{sense}} & & \text{Sensing temperature} \\ T_{\text{op}} & & \text{Operating temperature} \\ T_{\text{PTC}} & & \text{PTC temperature} \end{array}$

 t_R Response time

T_{ref} Reference temperature

T_{Bmin} Temperature at minimum resistance

t_s Switching time

T_{surf} Surface temperature

UCT Upper category temperature

V or V_{el} Voltage (with subscript only for distinction from volume)

V_{RMS} Root-mean-square value of voltage

 V_{BD} Breakdown voltage V_{ins} Insulation test voltage $V_{link,max}$ Maximum link voltage V_{max} Maximum operating voltage

V_{max dvn} Maximum dynamic (short-time) operating voltage

V_{meas} Measuring voltage

V_{meas max} Maximum measuring voltage

V_B Rated voltage

V_{PTC} Voltage drop across a PTC thermistor

 $\begin{array}{ll} \alpha & & \text{Temperature coefficient} \\ \Delta & & \text{Tolerance, change} \\ \delta_{\text{th}} & & \text{Dissipation factor} \end{array}$

 τ_{th} Thermal cooling time constant

λ Failure rate

e Lead spacing (in mm)

Abbreviations / Notes

SMD Surface-mount devices

* To be replaced by a number in ordering codes, type designations etc.

+ To be replaced by a letter

All dimensions are given in mm.

The commas used in numerical values denote decimal points.



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